

Search Notes (continued)

Application/Control No.

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Examiner

Tan Dean D. Nguyen

Applicant(s)/Patent under
Reexamination

HSU ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR